



P-Channel 30 V (D-S) MOSFET

MOSFET PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$ Max.	I _D (A) ^a	Q _g (Typ.)		
	0.042 at V _{GS} = - 10 V	- 5			
- 30	0.054 at V _{GS} = - 6 V	- 4.4	6.9 nC		
	0.068 at V _{GS} = - 4.5 V	- 3.9			

FEATURES

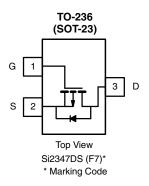
- TrenchFET® Power MOSFET
- 100 % R_g Tested
- Material categorization: For definitions of compliance please see www.vishav.com/doc?99912



HALOGEN FREE

APPLICATIONS

- Load Switch
- Notebook Adaptor Switch
- DC/DC Converter
- **Power Management**



Ordering Information: Si2347DS-T1-GE3 (Lead (Pb)-free and Halogen-free)

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V_{DS}	- 30	V	
Gate-Source Voltage	V_{GS}	± 20	<u> </u>	
	T _C = 25 °C		- 5	
Continuous Drain Current (T ₁ = 150 °C)	T _C = 70 °C	l .	- 4	
Continuous Brain Current (1) = 100 °C)	T _A = 25 °C	I _D	- 3.8 ^{b,c}	
	T _A = 70 °C		- 3 ^{b,c}	A
Pulsed Drain Current (t = 300 μs)	I _{DM}	- 20		
Continuous Source-Drain Diode Current	T _C = 25 °C	l _o	- 1.4	
Continuous Source-Diain Diode Current	T _A = 25 °C	I _S	- 0.63 ^{b,c}	
	T _C = 25 °C		1.7	
Maximum Power Dissipation	T _C = 70 °C	P_{D}	1.1	w
Maximum Fower Dissipation	T _A = 25 °C	' ^D	1.20 ^{b, c}	
	T _A = 70 °C		0.6 ^{b, c}	
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, d}	≤ 5 s	R_{thJA}	100	130	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	60	75	O/ VV	

Notes:

- a. Based on T_C = 25 °C.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 5 s.
- d. Maximum under steady state conditions is 175 °C/W.



Parameter Symbol Test Conditions Min. Typ. Max. Unit Static	MOSFET SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)							
Drain-Source Breakdown Voltage V _{DS} V _{DS} = 0 V, I _D = -250 μA -30 V V V V _{DS} Temperature Coefficient AV _{DS} (III) I _D = -250 μA -30 mV/°C MV/°C MV _{DS} (III) I _D = -250 μA -1 -2.5 V MV/°C MV/°C MV _{DS} (III) I _D = -250 μA -1 -2.5 V MV/°C MV _{DS} (III) I _D = -250 μA -1 -2.5 V MV/°C MV _{DS} (III) I _D = -250 μA -1 -2.5 V MV/°C MV _{DS} (III) I _D = -250 μA -1 -2.5 V MV/°C MV _{DS} (III) I _D = -250 μA -1 -2.5 V MV/°C MV _{DS} (III) I _D = -250 μA -1 -2.5 V MV/°C MV/°	Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Vos Temperature Coefficient	Static	Static						
Vosition	Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V, } I_{D} = -250 \mu\text{A}$	- 30			V	
Vaskin temperature Coefficient AVGs(m) V_DS = V_GS. b = -250 μA -1 -2.5 V	V _{DS} Temperature Coefficient		L = 250 uA		- 25		mV/°C	
Gate-Source Leakage	V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$,		3.9			
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = -250 \mu A$	- 1		- 2.5	V	
Description	Gate-Source Leakage	I _{GSS}				± 100	nA	
On-State Drain Current® ID _(on) V _{DS} ≤ - 5 V, V _{GS} = -10 V, I _D = 5 °C -10 A Drain-Source On-State Resistance® R _{DS(on)} V _{GS} = -10 V, I _D = -3.8 A 0.033 0.042 Ω Forward Transconductance® g _{Is} V _{DS} = -5 V, I _D = -3.8 A 0.050 0.068 0.050 0.068 Forward Transconductance® g _{Is} V _{DS} = -5 V, I _D = -3.8 A 10 S S Dynamic* Duptut Capacitance C _{Iss} V _{DS} = -5 V, I _D = -3.8 A 10 S S Reverse Transfer Capacitance C _{Iss} V _{DS} = -15 V, V _{GS} = 0 V, f = 1 MHz 93 pF pF Total Gate Charge Q _g V _{DS} = -15 V, V _{GS} = -10 V, I _D = -5 A 14.5 22 nC Gate-Drain Charge Q _g V _{DS} = -15 V, V _{QS} = -4.5 V, I _D = -5 A 14.5 22 nC Gate-Besistance R _g f = 1 MHz 1.7 8.3 17 Ω Turn-Oft Delay Time I _t (cin) V _{DD} = -15 V, R _L = 5 Ω 6 12 ns ns Fall Time <	Zero Gate Voltage Drain Current	lpaa	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}$			- 1	μΑ	
Drain-Source On-State Resistance Position Positi	Zero date voltage Drain Gurrent	פטי	V_{DS} = - 30 V, V_{GS} = 0 V, T_J = 55 °C			- 10		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le$ - 5 V, V_{GS} = - 10 V	- 20			Α	
Vos = -4.5 V, Ip = -3 A 0.050 0.068			V _{GS} = - 10 V, I _D = - 3.8 A		0.033	0.042	Ω	
Promain Pro	Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 6 V, I _D = - 3.3 A		0.041	0.054		
Input Capacitance			$V_{GS} = -4.5 \text{ V}, I_D = -3 \text{ A}$		0.050	0.068		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Forward Transconductance ^a	9 _{fs}	V _{DS} = - 5 V, I _D = - 3.8 A		10		S	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Dynamic ^b					'		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Input Capacitance	C _{iss}			705			
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Output Capacitance		$V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		93		pF	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Reverse Transfer Capacitance				73			
Gate-Source Charge Q_{gs} $V_{DS} = -15$ V, $V_{GS} = -4.5$ V, $I_{D} = -5$ A 6.9 10.4 nC Gate-Drain Charge Q_{gd} 2.3 -2.3 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1 -2.1	T. 10 . 0		V _{DS} = - 15 V, V _{GS} = - 10 V, I _D = - 5 A		14.5	22		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Total Gate Charge	Q_{g}			6.9	10.4		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Gate-Source Charge	Q_{gs}	$V_{DS} = -15 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -5 \text{ A}$		2.3		nC	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Gate-Drain Charge				2.1			
Rise Time t_r $V_{DD} = -15 \text{ V}, R_L = 5 \Omega$ 6 12 Turn-Off Delay Time t_d 19 29 Fall Time 9 18 Turn-On Delay Time t_d 9 18 Turn-Off Delay Time t_d $V_{DD} = -15 \text{ V}, R_L = 5 \Omega$ 9 18 Turn-Off Delay Time t_d $V_{DD} = -15 \text{ V}, R_L = 5 \Omega$ 9 18 27 Fall Time t_f $I_D = -3 \text{ A}, V_{GEN} = -6 \text{ V}, R_G = 1 \Omega$ 18 27 14 Drain-Source Body Diode Characteristics Continuous Source-Drain Diode Current I_S $I_S = -3 \text{ C}$ $I_S = -3 \text{ A}$ $I_S = -3 $	Gate Resistance		f = 1 MHz	1.7	8.3	17	Ω	
Rise Time t_r $V_{DD} = -15 \text{ V}, R_L = 5 \Omega$ 6 12 Turn-Off Delay Time t_d 19 29 Fall Time 9 18 Turn-On Delay Time t_d 9 18 Turn-Off Delay Time t_d $V_{DD} = -15 \text{ V}, R_L = 5 \Omega$ 9 18 Turn-Off Delay Time t_d $V_{DD} = -15 \text{ V}, R_L = 5 \Omega$ 9 18 27 Fall Time t_f $I_D = -3 \text{ A}, V_{GEN} = -6 \text{ V}, R_G = 1 \Omega$ 18 27 14 Drain-Source Body Diode Characteristics Continuous Source-Drain Diode Current I_S $I_S = -3 \text{ C}$ $I_S = -3 \text{ A}$ $I_S = -3 $	Turn-On Delay Time	t _{d(on)}			6	12		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Rise Time		V_{DD} = - 15 V, R_L = 5 Ω		6	12	ns	
	Turn-Off Delay Time	t _{d(off)}	I_D = - 3 A, V_{GEN} = - 10 V, R_G = 1 Ω		19	29		
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	Fall Time				9	18		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Turn-On Delay Time	t _{d(on)}			10	20		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Rise Time	t _r	V_{DD} = - 15 V, R_L = 5 Ω		9	18	- ns	
	Turn-Off Delay Time	t _{d(off)}	I_D = - 3 A, V_{GEN} = - 6 V, R_G = 1 Ω		18	27		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Fall Time	t _f			7	14		
Pulse Diode Forward Current ^a I_{SM} -20 Body Diode Voltage V_{SD} $I_S = -3$ A -0.8 -1.2 V Body Diode Reverse Recovery Time t_{rr} 13 20 ns Body Diode Reverse Recovery Charge Q_{rr} Reverse Recovery Fall Time t_a $I_F = -3$ A, $dI/dt = 100$ A/ μ s, $T_J = 25$ °C T_{rot} T_{rot} T_{rot}	Drain-Source Body Diode Characteristics							
Pulse Diode Forward Current ^a Body Diode Voltage V _{SD} V_{SD} V_{SD} V_{SD} V_{SD} Body Diode Reverse Recovery Time V_{rr} Body Diode Reverse Recovery Charge V_{rr} Reverse Recovery Fall Time V_{SD}	Continuous Source-Drain Diode Current	I _S	$T_C = 25 ^{\circ}C$			- 1.4	۸	
Body Diode Reverse Recovery Time t_{rr} Body Diode Reverse Recovery Charge Q_{rr} Reverse Recovery Fall Time t_a $I_F = -3 \text{ A, dl/dt} = 100 \text{ A/µs, T}_J = 25 \text{ °C}$ 7 ns	Pulse Diode Forward Current ^a	I _{SM}				- 20	^	
Body Diode Reverse Recovery Charge Q_{rr} $I_F = -3 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$ T	Body Diode Voltage	V_{SD}	I _S = - 3 A		- 0.8	- 1.2	V	
Reverse Recovery Fall Time t_a $I_F = -3 \text{ A}$, $dI/dt = 100 \text{ A/µs}$, $I_J = 25 \text{ °C}$ 7	Body Diode Reverse Recovery Time	t _{rr}			13	20	ns	
Reverse Recovery Fall Time t _a 7	Body Diode Reverse Recovery Charge	Q _{rr}	L 2 A dl/dt _ 100 A/v2 T _ 25 °C		5	10	nC	
Reverse Recovery Rise Time t _b 6	Reverse Recovery Fall Time	t _a	$I_{\rm F} = -3$ A, dI/dt = 100 A/ μ s, $I_{\rm LI} = 25$ °C		7			
	Reverse Recovery Rise Time	t _b			6		- ns	

Notes:

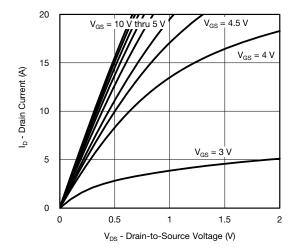
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$

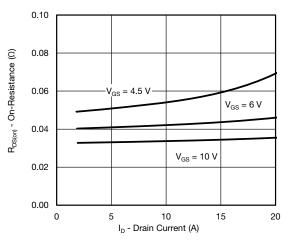
b. Guaranteed by design, not subject to production testing.



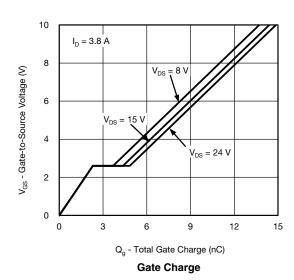
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

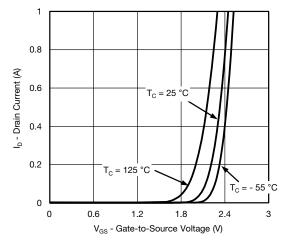


Output Characteristics

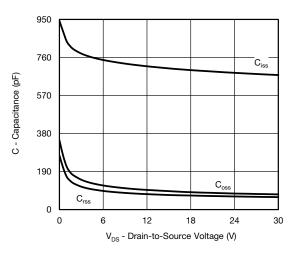


On-Resistance vs. Drain Current and Gate Voltage

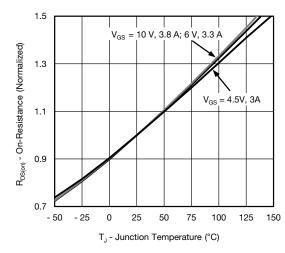




Transfer Characteristics

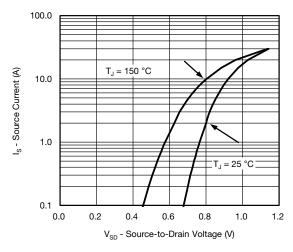


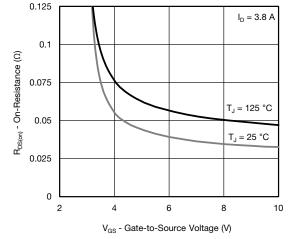
Capacitance



On-Resistance vs. Junction Temperature

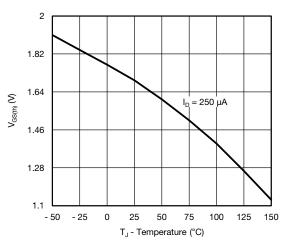
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

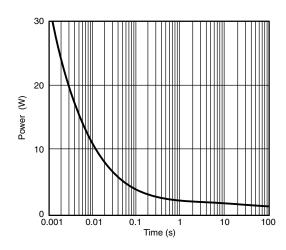




Source-Drain Diode Forward Voltage

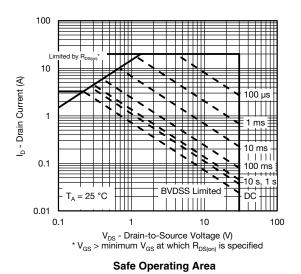
On-Resistance vs. Gate-to-Source Voltage





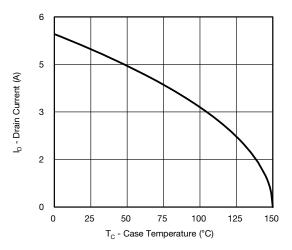
Threshold Voltage

Single Pulse Power

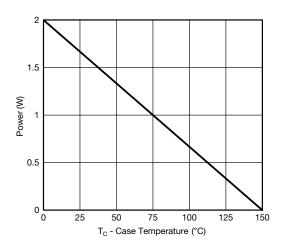




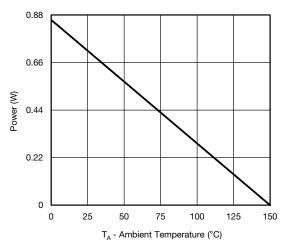
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating*





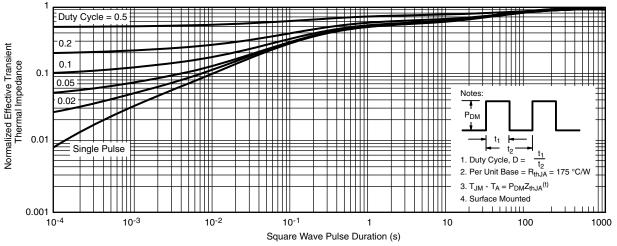


Power, Junction-to-Ambient

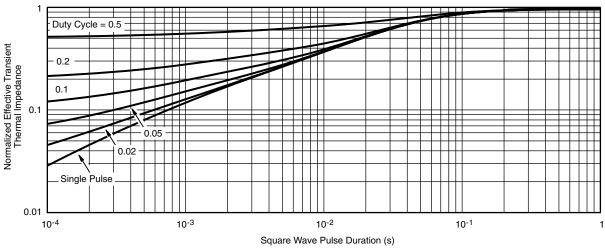
^{*} The power dissipation PD is based on TJ(max.) = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heats inking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



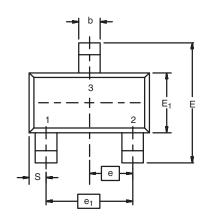
Normalized Thermal Transient Impedance, Junction-to-Ambient

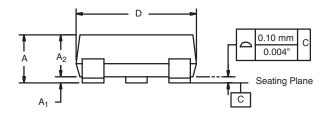


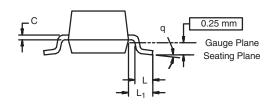
Normalized Thermal Transient Impedance, Junction-to-Foot

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?62827.

SOT-23 (TO-236): 3-LEAD







Dim	MILLI	METERS	INCHES			
	Min	Max	Min	Max		
Α	0.89	1.12	0.035	0.044		
A ₁	0.01	0.10	0.0004	0.004		
A ₂	0.88	1.02	0.0346	0.040		
b	0.35	0.50	0.014	0.020		
С	0.085	0.18	0.003	0.007		
D	2.80	3.04	0.110	0.120		
E	2.10	2.64	0.083	0.104		
E ₁	1.20	1.40	0.047	0.055		
е	0.95 BSC		0.037	0.0374 Ref		
e ₁	1.90 BSC		0.074	0.0748 Ref		
L	0.40	0.60	0.016	0.024		
L ₁	0.64 Ref		0.025	5 Ref		
S	0.50 Ref		0.020) Ref		
q	3°	8°	3°	8°		
FCN: S-03946-Rev K 09-	lul-01	•				

ECN: S-03946-Rev. K, 09-Jul-01

DWG: 5479

Document Number: 71196 www.vishay.com 09-Jul-01





Mounting LITTLE FOOT® SOT-23 Power MOSFETs

Wharton McDaniel

Surface-mounted LITTLE FOOT power MOSFETs use integrated circuit and small-signal packages which have been been modified to provide the heat transfer capabilities required by power devices. Leadframe materials and design, molding compounds, and die attach materials have been changed, while the footprint of the packages remains the same.

See Application Note 826, Recommended Minimum Pad Patterns With Outline Drawing Access for Vishay Siliconix MOSFETs, (http://www.vishay.com/doc?72286), for the basis of the pad design for a LITTLE FOOT SOT-23 power MOSFET footprint. In converting this footprint to the pad set for a power device, designers must make two connections: an electrical connection and a thermal connection, to draw heat away from the package.

The electrical connections for the SOT-23 are very simple. Pin 1 is the gate, pin 2 is the source, and pin 3 is the drain. As in the other LITTLE FOOT packages, the drain pin serves the additional function of providing the thermal connection from the package to the PC board. The total cross section of a copper trace connected to the drain may be adequate to carry the current required for the application, but it may be inadequate thermally. Also, heat spreads in a circular fashion from the heat source. In this case the drain pin is the heat source when looking at heat spread on the PC board.

Figure 1 shows the footprint with copper spreading for the SOT-23 package. This pattern shows the starting point for utilizing the board area available for the heat spreading copper. To create this pattern, a plane of copper overlies the drain pin and provides planar copper to draw heat from the drain lead and start the process of spreading the heat so it can be dissipated into the ambient air. This pattern uses all the available area underneath the body for this purpose.

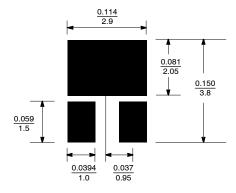


FIGURE 1. Footprint With Copper Spreading

Since surface-mounted packages are small, and reflow soldering is the most common way in which these are affixed to the PC board, "thermal" connections from the planar copper to the pads have not been used. Even if additional planar copper area is used, there should be no problems in the soldering process. The actual solder connections are defined by the solder mask openings. By combining the basic footprint with the copper plane on the drain pins, the solder mask generation occurs automatically.

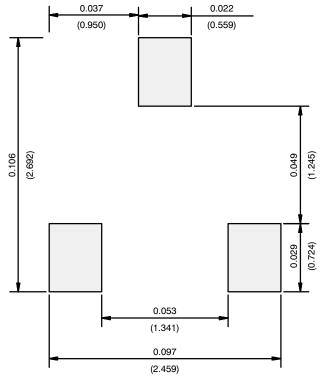
A final item to keep in mind is the width of the power traces. The absolute minimum power trace width must be determined by the amount of current it has to carry. For thermal reasons, this minimum width should be at least 0.020 inches. The use of wide traces connected to the drain plane provides a low-impedance path for heat to move away from the device.

Document Number: 70739

26-Nov-03



RECOMMENDED MINIMUM PADS FOR SOT-23



Recommended Minimum Pads Dimensions in Inches/(mm)

Return to Index

APPLICATION NOTE



Legal Disclaimer Notice

Vishay

Disclaimer

ALL PRODUCT, PRODUCT SPECIFICATIONS AND DATA ARE SUBJECT TO CHANGE WITHOUT NOTICE TO IMPROVE RELIABILITY, FUNCTION OR DESIGN OR OTHERWISE.

Vishay Intertechnology, Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Vishay"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained in any datasheet or in any other disclosure relating to any product.

Vishay makes no warranty, representation or guarantee regarding the suitability of the products for any particular purpose or the continuing production of any product. To the maximum extent permitted by applicable law, Vishay disclaims (i) any and all liability arising out of the application or use of any product, (ii) any and all liability, including without limitation special, consequential or incidental damages, and (iii) any and all implied warranties, including warranties of fitness for particular purpose, non-infringement and merchantability.

Statements regarding the suitability of products for certain types of applications are based on Vishay's knowledge of typical requirements that are often placed on Vishay products in generic applications. Such statements are not binding statements about the suitability of products for a particular application. It is the customer's responsibility to validate that a particular product with the properties described in the product specification is suitable for use in a particular application. Parameters provided in datasheets and / or specifications may vary in different applications and performance may vary over time. All operating parameters, including typical parameters, must be validated for each customer application by the customer's technical experts. Product specifications do not expand or otherwise modify Vishay's terms and conditions of purchase, including but not limited to the warranty expressed therein.

Except as expressly indicated in writing, Vishay products are not designed for use in medical, life-saving, or life-sustaining applications or for any other application in which the failure of the Vishay product could result in personal injury or death. Customers using or selling Vishay products not expressly indicated for use in such applications do so at their own risk. Please contact authorized Vishay personnel to obtain written terms and conditions regarding products designed for such applications.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document or by any conduct of Vishay. Product names and markings noted herein may be trademarks of their respective owners.